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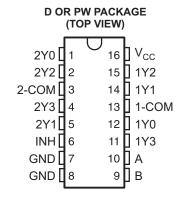
SCLS469D - MARCH 2003 - REVISED JUNE 2011

DUAL 4-CHANNEL ANALOG MULTIPLEXERS/DEMULTIPLEXERS

Check for Samples: SN74LV4052A-Q1

FEATURES

- Qualified for Automotive Applications
- Supports Mixed-Mode Voltage Operation on All Ports
- Fast Switching
- · High On-Off Output-Voltage Ratio
- Low Crosstalk Between Switches
- Extremely Low Input Current
- Latch-Up Performance Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



DESCRIPTION

These dual 4-channel CMOS analog multiplexers/demultiplexers are designed for 2-V to 5.5-V V_{CC} operation.

The 'LV4052A devices handle both analog and digital signals. Each channel permits signals with amplitudes up to 5.5 V (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

ORDERING INFORMATION(1)

T _A	PACE	(AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 105°C	SOIC - D	Tape and reel	SN74LV4052ATDRQ1	L4052AQ
-40 C to 105 C	TSSOP - PW	Tape and reel	SN74LV4052ATPWRQ1	L4052AQ
–40°C to 125°C	TSSOP – PW	Tape and reel	SN74LV4052AQPWRQ1	4052AQ1

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

FUNCTION TABLE

	INPUTS		ON
INH	В	Α	CHANNEL
L	L	L	1Y0, 2Y0
L	L	Н	1Y1, 1Y1
L	Н	L	1Y2, 2Y2
L	Н	Н	1Y3, 2Y3
Н	Χ	Χ	None

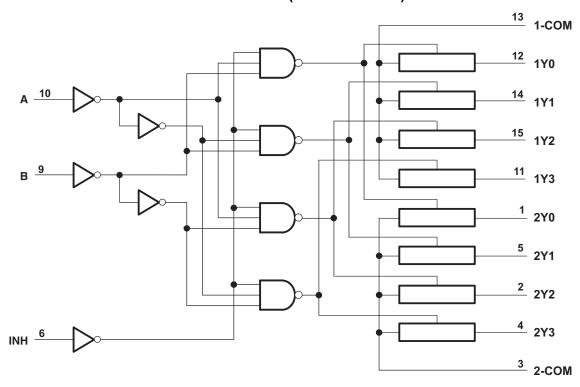


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

⁽²⁾ Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



LOGIC DIAGRAM (POSITIVE LOGIC)



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ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

1 3 1 3 - (-	,		
Supply voltage range	Supply voltage range		
Input voltage range ⁽²⁾		–0.5 V to 7 V	
Switch I/O voltage range (2) (3)		–0.5 V to V _{CC} + 0.5 V	
Input clamp current	V _I < 0	–20 mA	
I/O diode current	V _{IO} < 0	–50 mA	
Switch through current	$V_{IO} = 0$ to V_{CC}	±25 mA	
Continuous current through V _{CC} or GND		±50 mA	
Declare the week increase (4)	D package	73°C/W	
Package thermal impedance **	PW package	108°C/W	
Storage temperature range		−65°C to 150°C	
	Supply voltage range Input voltage range ⁽²⁾ Switch I/O voltage range ⁽²⁾ Input clamp current I/O diode current Switch through current Continuous current through V _{CC} or GND Package thermal impedance ⁽⁴⁾	$\begin{array}{c c} & \text{Input voltage range}^{(2)} \\ & \text{Switch I/O voltage range}^{(2)} & \text{Switch I/O voltage range}^{(2)} & \text{Switch I/O voltage range}^{(2)} & \text{Switch I/O diode current} & \text{V}_{\text{IO}} < 0 \\ & \text{I/O diode current} & \text{V}_{\text{IO}} < 0 \\ & \text{Switch through current} & \text{V}_{\text{IO}} = 0 \text{ to V}_{\text{CC}} \\ & \text{Continuous current through V}_{\text{CC}} \text{ or GND} \\ & \text{Package thermal impedance}^{(4)} & \text{D package} \\ & \text{PW package} \\ & \text{PW package} \\ & \end{array}$	

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

RECOMMENDED OPERATING CONDITIONS(1)

			MIN	MAX	UNIT	
V_{CC}	Supply voltage		2 ⁽²⁾	5.5	V	
		V _{CC} = 2 V	1.5			
V	High-level input voltage,	V _{CC} = 2.3 V to 2.7 V	$V_{CC} \times 0.7$		V	
V _{IH}	control inputs	V _{CC} = 3 V to 3.6 V	V _{CC} × 0.7		V	
		V _{CC} = 4.5 V to 5.5 V	V _{CC} × 0.7			
		V _{CC} = 2 V		0.5		
V	V _{IL} Low-level input voltage, control inputs				$V_{CC} \times 0.3$	V
VIL					$V_{CC} \times 0.3$	V
		V_{CC} = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		
V_{I}	Control input voltage		0	5.5	٧	
V_{IO}	Input/output voltage		0	V_{CC}	٧	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200		
Δt/Δν	Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V		100	ns/V	
		V _{CC} = 4.5 V to 5.5 V		20		
T _A	Operating free-air temperature	SN74LV4052ATDRQ1,SN74LV4052ATPWRQ1	-40	105	°C	
T _A	Operating free-air temperature	SN74LV4052AQPWRQ1	-40	125	C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

⁽³⁾ This value is limited to 5.5 V maximum.

⁽⁴⁾ The package thermal impedance is calculated in accordance with JESD 51-7.

⁽²⁾ With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.



ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{cc}	T _A = -40 to 105°C	T _A = -40 to 125°C	UNIT
				MIN MAX	MIN MAX	
		I _T = 2 mA,	2.3 V	225	225	
r _{on}	On-state switch resistance	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IL}$	3 V	190	190	Ω
		(see Figure 1)	4.5 V	100	100	
		$I_T = 2 \text{ mA},$	2.3 V	600	600	
r _{on(p)}	Peak on-state resistance	$V_1 = V_{CC}$ or GND,	3 V	225	225	Ω
",		$V_{INH} = V_{IL}$	4.5 V	125	125	
		$I_T = 2 \text{ mA},$	2.3 V	40	40	
Δr_{on}	Difference in on-state resistance between switch	$V_1 = V_{CC}$ or GND,	3 V	30	30	Ω
	resistance between switch	$V_{INH} = V_{IL}$	4.5 V	20	20	
I	Control input current	V _I = 5.5 V or GND	0 V to 5.5 V	±1	±2	μΑ
I _{S(off)}	Off-state switch leakage current	$\begin{aligned} &V_{I} = V_{CC} \text{ and } \\ &V_{O} = \text{GND, or } \\ &V_{I} = \text{GND and } \\ &V_{O} = V_{CC}, \\ &V_{INH} = V_{IH} \\ &(\text{see Figure 2}) \end{aligned}$	5.5 V	±1	±2	μА
I _{S(on)}	On-state switch leakage current	$V_{I} = V_{CC}$ or GND, $V_{INH} = V_{IL}$ (see Figure 3)	5.5 V	±1	±2	μΑ
I _{CC}	Supply current	$V_I = V_{CC}$ or GND	5.5 V	20	40	μΑ

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SWITCHING CHARACTERISTICS

 V_{CC} = 3.3 V ± 0.3 V, over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		FROM	то	TEST CONDITIONS	T _A = -40 to 105°C	T _A = -40 to 125°C	UNIT
F	ARAMETER	(INPUT)	(OUTPUT	TEST CONDITIONS	MIN MAX	MIN MAX	UNIT
t _{PLH}	Propagation delay time	COM or Y	Y or COM	C _L = 50 pF (see Figure 4)	12	14	ns
t _{PZH}	Enable delay time	INH	COM or Y	C _L = 50 pF (see Figure 5)	25	25	ns
t _{PHZ}	Disable delay time	INH	COM or Y	C _L = 50 pF (see Figure 5)	25	25	ns

SWITCHING CHARACTERISTICS

 $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$, over recommended operating free-air temperature range (unless otherwise noted)

	AD AMETED	FROM	то	TEST CONDITIONS	T _A = -40 to 105°C	T _A = -40 to 125°C	LINUT
F	PARAMETER	(INPUT)	(OUTPUT	TEST CONDITIONS	MIN MAX	MIN MAX	UNIT
t _{PLH}	Propagation delay time	COM or Y	Y or COM	C _L = 50 pF (see Figure 4)	8	10	ns
t _{PZH}	Enable delay time	INH	COM or Y	C _L = 50 pF (see Figure 5)	18	18	ns
t_{PHZ} t_{PLZ}	Disable delay time	INH	COM or Y	C _L = 50 pF (see Figure 5)	18	18	ns



ANALOG SWITCH CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	FROM	то	TEST COM	TEST CONDITIONS		T _A	= 25°C		UNIT		
PARAMETER	(INPUT)	(OUTPUT)	TEST CONL	DITIONS	V _{CC}	MIN	TYP	MAX	UNIT		
			$C_L = 50 \text{ pF},$		2.3 V		30				
Frequency response (switch on)	COM or Y	Y or COM	$R_L = 600 \Omega$, $f_{in} = 1 MHz$ (sine wa	ave) (1)	3 V		35		MHz		
(ounton on)			(see Figure 6)	4.0)	4.5 V		50				
Crosstalk			$C_L = 50 \text{ pF},$		2.3 V		– 45				
(between any	COM or Y	Y or COM	$R_L = 600 \Omega$, $f_{in} = 1 MHz$ (sine wa	ave)	3 V		– 45		dB		
switches))			(seeFigure 7)				4.5 V		– 45		
Crosstalk			$C_L = 50 \text{ pF},$		2.3 V		20				
(control input to signal	INH	COM or Y	$R_L = 600 \Omega$, $f_{in} = 1 \text{ MHz (square wave)}$		3 V		35		mV		
output)			(see Figure 8)	wave	4.5 V		65				
Feedthrough			$C_L = 50 \text{ pF},$		2.3 V		-45				
attenuation	COM or Y	Y or COM	$R_L = 600 \Omega,$ $f_{in} = 1 \text{ MHz}^{(2)}$		3 V		-45		dB		
(switch off)			(see Figure 9)		4.5 V		-45				
			$C_L = 50 \text{ pF},$	V _I = 2 Vp-p	2.3 V		0.1				
Sine-wave distortion	COM or Y	Y or COM	$R_L = 10 \text{ k}\Omega$,	V _I = 2.5 Vp-p	3 V		0.1		%		
Sine-wave distortion			f _{in} = 1 kHz (sine wave) (see Figure 10)	V _I = 4 Vp-p	4.5 V		0.1		/0		

⁽¹⁾ Adjust f_{in} voltage to obtain 0-dBm output. Increase fin frequency until dB meter reads −3 dB.

OPERATING CHARACTERISTICS

 $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C} \text{ (unless otherwise noted)}$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd}	Power dissipation capacitance	C _L = 50 pF, f = 10 MHz	11.8	pF

⁽²⁾ Adjust fin voltage to obtain 0-dBm input.



PARAMETER MEASUREMENT INFORMATION

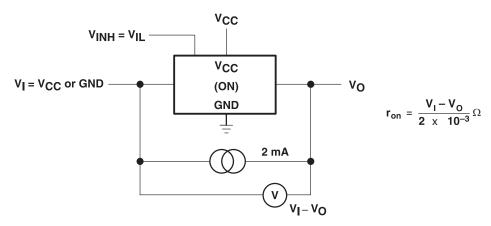
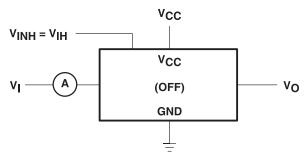


Figure 1. On-State Resistance Test Circuit



Condition 1: $V_I = 0$, $V_O = V_{CC}$ Condition 2: $V_I = V_{CC}$, $V_O = 0$

Figure 2. Off-State Switch Leakage-Current Test Circuit

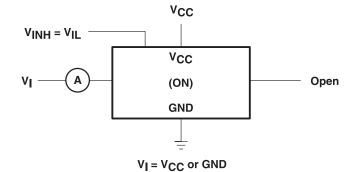


Figure 3. On-State Switch Leakage-Current Test Circuit

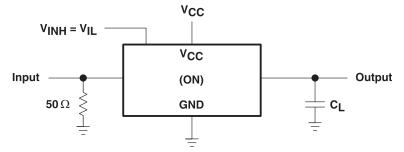
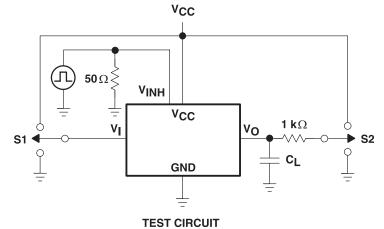


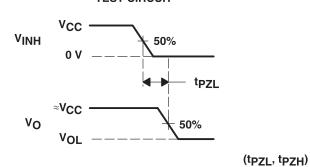
Figure 4. Propagation Delay Time, Signal Input to Signal Output

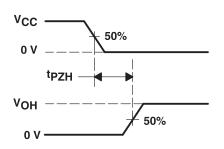


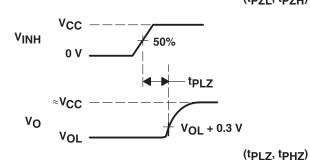
PARAMETER MEASUREMENT INFORMATION (continued)

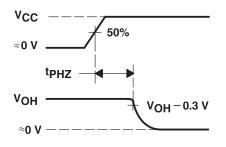


TEST	S1	S2
t _{PLZ} /t _{PZL}	GND	V _{CC}
t _{PHZ} /t _{PZH}	V _{CC}	GND



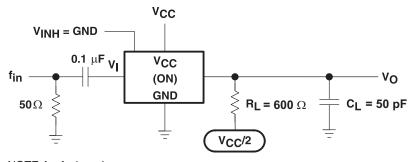






VOLTAGE WAVEFORMS

Figure 5. Switching Time (t_{PZL} , t_{PLZ} , t_{PZH} , t_{PHZ}), Control to Signal Output

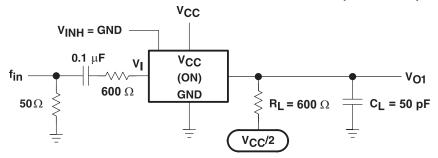


NOTE A: fin is a sine wave.

Figure 6. Frequency Response (Switch On)



PARAMETER MEASUREMENT INFORMATION (continued)



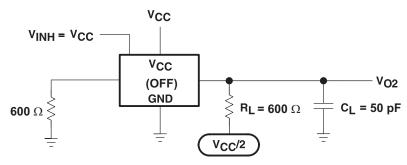


Figure 7. Crosstalk Between Any Two Switches

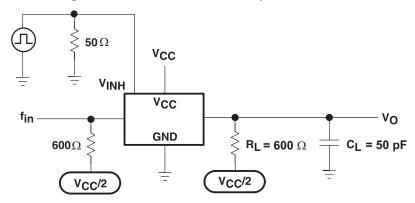


Figure 8. Crosstalk Between Control Input and Switch Output

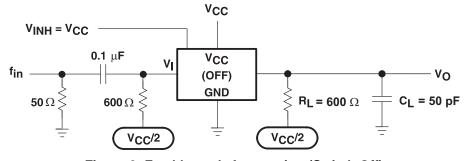


Figure 9. Feedthrough Attenuation (Switch Off)



PARAMETER MEASUREMENT INFORMATION (continued)

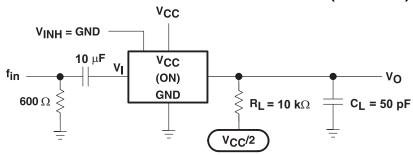


Figure 10. Sine-Wave Distortion





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CLV4052ATPWRG4Q1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV4052AQPWRQ1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV4052ATDRQ1	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74LV4052ATPWRQ1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74LV4052A-Q1:





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● Catalog: SN74LV4052A

● Enhanced Product: SN74LV4052A-EP

NOTE: Qualified Version Definitions:

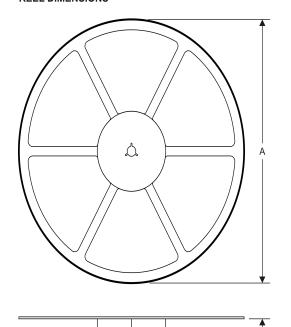
- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

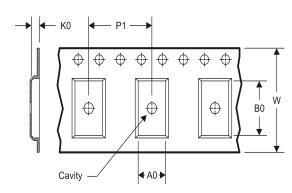
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TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV4052AQPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV4052AQPWRQ1	TSSOP	PW	16	2000	367.0	367.0	35.0

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

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